

# Overview and Expected Performance of RF Beam Diagnostics

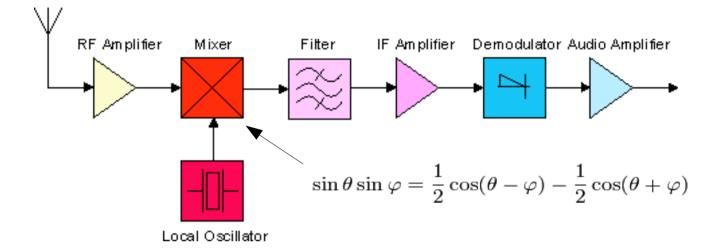
Trent Allison, Brian Bevins, Keith Cole, Roger Flood, Omar Garza, John Musson, and Dave Williams

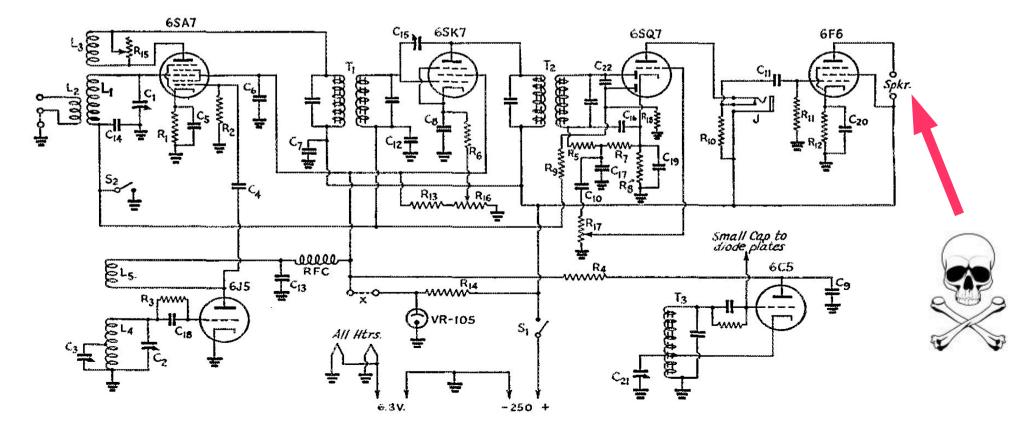
8/6/2015

# Overview

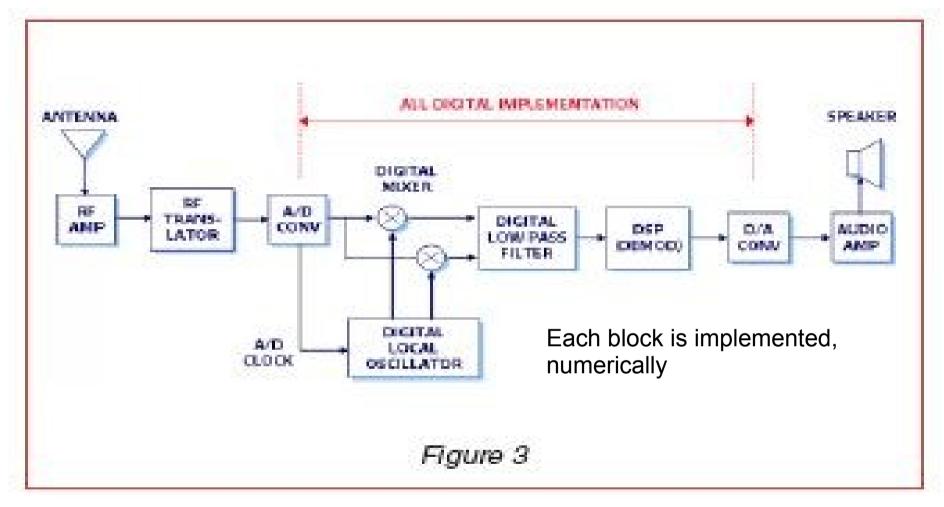
- Receiver Architecture
- Stripline BPMs
- Cavity BPMs
- BCM
- Goubau Line Testing
- Conclusions
- References

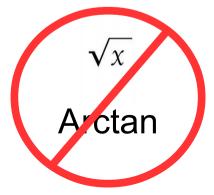
## Superheterodyne Architecture





## **Digital Receiver**

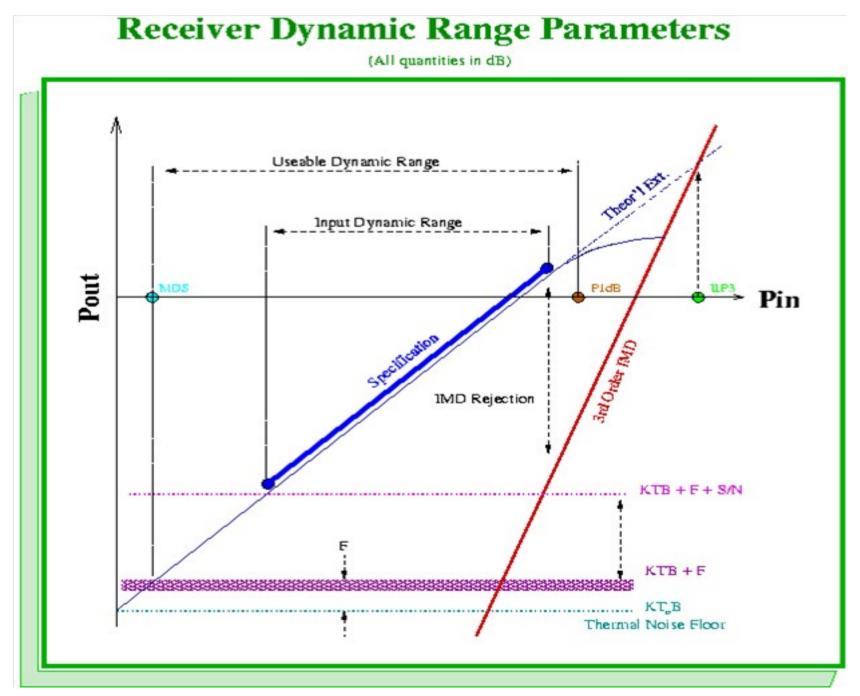




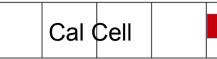
#### Nearly always integer math!!!

**JLAB-TN-14-028**. "Functional Description of Algorithms Used in Digital Receivers" https://jlabdoc.jlab.org/docushare/dsweb/View/Collection-21302

## System Linearity



#### RECEIVER MODEL



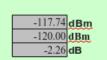
#### Downconverter

Input Field			Coax	LNA	Filter	Amp	Coax	LNA	Filter	Amp	Filter	Mixer	IF Filter	Атр	
Noise Figure Gain: <u>Passband</u>			4.00	1.30	3.00	5.40 18.00	10.00	1.30	3.00	5.40 18.00	1.00	8.00 -8.00		2.70	2.70 dB 15.00 dB
Gain: Reject-band IIP3			-4.00 200.00	13.00 28.00	-20.00 200.00	18.00 26.00	-10.00 200.00	13.00 28.00	-20.00 200.00	18.00 26.00	-20.00 200.00	-8.00 34.00	-30.00	15.00 21.00	15.00 dB 23.00 dBm
P1dB Return Loss			200.00 8.00	23.00 20.00	200.00 6.00	20.00 20.00	200.00 20.00	23.00 20.00	200.00 6.00	20.00 20.00	200.00 2.00	22.00 16.00		20.00 25.00	20.00 dBm 25.00 dB
Pin Interference Pin <u>Passband</u> Input Noise BW Input Noise Temperature Input Noise Level Required C/N Required Sensitivity	<ul> <li>✓</li> <li>✓</li></ul>	-33.00 -33.00 50.00 290.00 -124.0 0.00 -120.00	dBm dB-Hz ( K ( dBm dB (	System IF BV IEEE definitio Modulator / E From "Specif	on = 290K fo ER -depende	entsee BER									

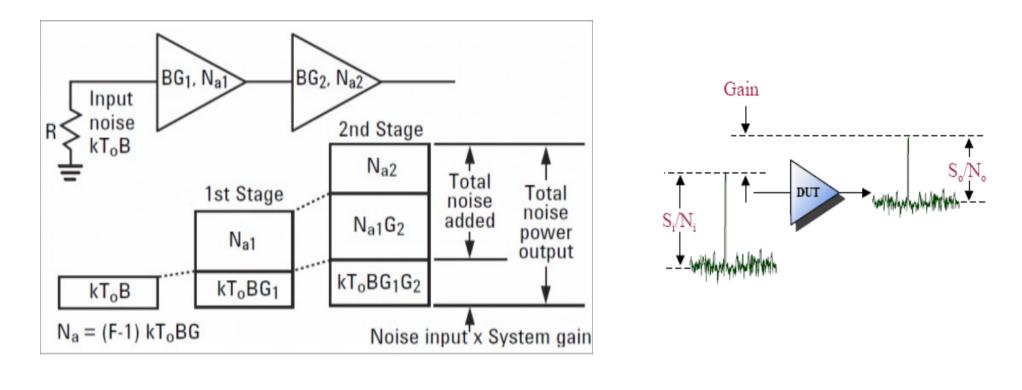
#### Calculation Field

												(	)
System Noise Figure	4.00	5.30	5.46	6.16	6.20	6.22	6.22	6.23	6.23	6.23	6.23	6.24	6.24 dB
System Noise Temp	26.42	28.41	28.63	29.58	29.63	29.65	29.66	29.67	29.67	29.67	29.67	29.68	29.68 dBK
System Gain: <u>Passband</u>	-4.00	9,00	6.00	24.00	14.00	27.00	24.00	42.00	41.00	33.00	27.00	29.00	44.00 dB
System Gain: Reject-band	-4.00	9.00	-11.00	7.00	-3.00	10.00	-10.00	8.00	-12.00	-20.00	-50.00	12.00	27.00 dB
IIP3: Passband	200.00	32.00	32.00	19.73	19.73	12.97	12.97	1.67	1.67	-7.55	-7.55	6.77	-6.22 dBm
IIP3: Reject-band	200.00	32.00	32.00	30.81	30.81	27.89	27.89	27.27	27.27	27.21	27.21	23.18	10.74 dBm
Input Spurious-Free Dynamic Range	213.32	100.45	100.35	91.70	91.67	87.16	87.15	79.61	79.61	73.46	73.46	83.01	74.34 dB
Pout: Passband	-37.00	-24.00	-27.00	-9.00	-19.00	-6.00	-9.00	9.00	8.00	0.00	-6.00	-4.00	11.00 dBm
Pout: Reject-band	-37.00	-24.00	-44.00	-26.00	-36.00	-23.00	-43.00	-25.00	-45.00	-53.00	-83.00	-21.00	-6.00 dBm
Output Noise Power	-123.98	-109.68	-112.52	-93.81	-103.78	-90.76	-93.76	-75.75	-76.75	-84.75	-90.75	-88.74	-73.74 dBm
C/N Ratio	86.98	85.68	85.52	84.81	84.78	84.76	84.76	84.75	84.75	84.75	84.75	84.74	84.74 dB
Saturation?	NO												
IIM3	-499.00	-163.00	-163.00	-160.61	-160.61	-154.78	-154.78	-153.54	-153.54	-153.42	-153.42	-145.35	-120.49 dBm
C/I Ratio	466.00	130.00	130.00	127.61	127.61	121.78	121.78	120.54	120.54	120.42	120.42	112.35	87.49 dB
Total Return Loss	8.00	28.00	34.00	54.00	74.00	94.00	100.00	120.00	122.00	138.00	150.00	99.00	124.00 dB

Calculated Receiver Sensitivity: Required Receiver Sensitivity: Margin:



## **Noise Calibration**

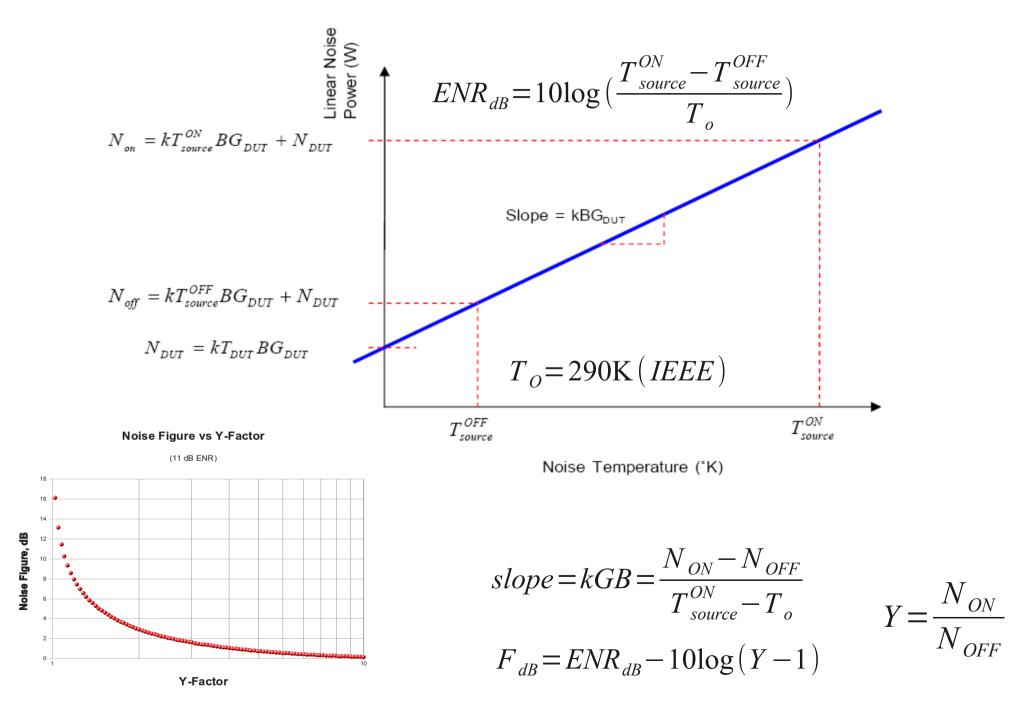


$$F_{sys} = F_1 + \frac{F_2 - 1}{G_1} + \frac{F_3 - 1}{G_1 G_2} + \frac{F_4 - 1}{G_1 G_2 G_3} + \dots$$

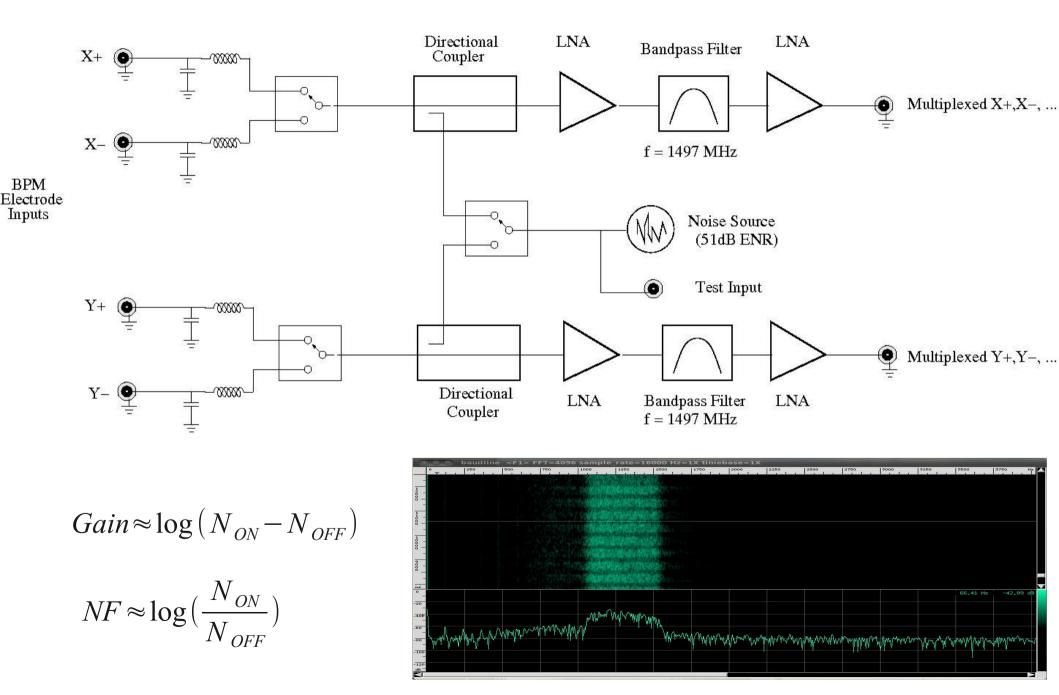
If loads are characterized, a 2-point calibration is possible:

Hot load: Room temperature (300 K), or noise source (3770 K) Cold load: LN2 or room temperature (300 K)

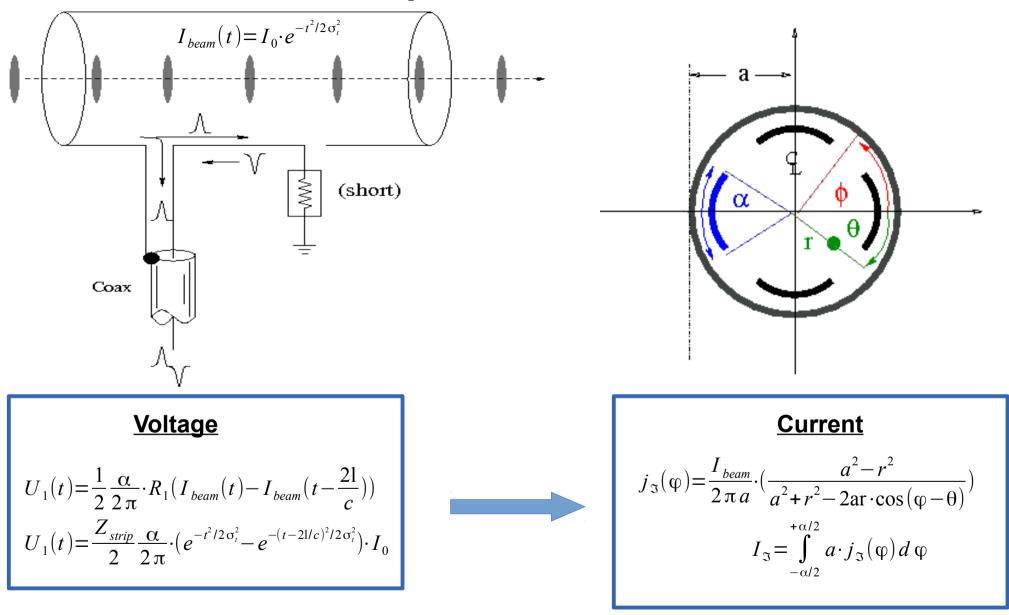
## Y-Factor Calibration Method



## **Implementation: Calibration Cell**



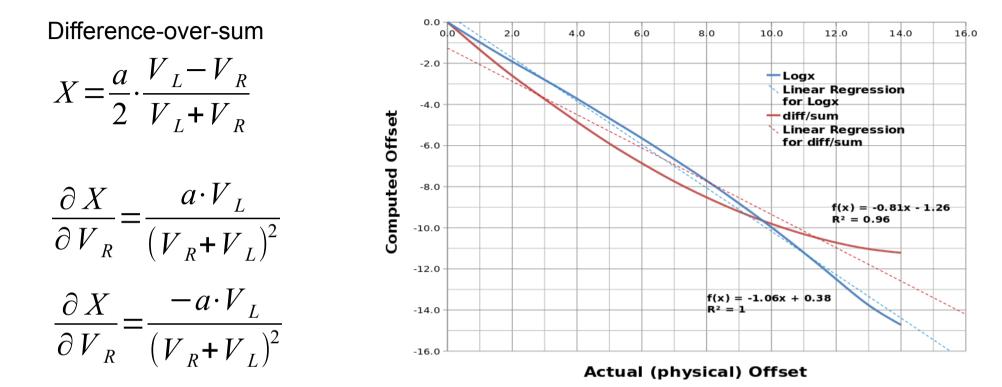
## **Stripline BPMs**



$$Z_{t}(\omega) = \frac{Z_{strip} \cdot \alpha}{4\pi} \cdot e^{-\omega^{2}\sigma_{t}^{2}/2} \cdot \sin(\omega l/c) \cdot e^{i(\pi/2 - \omega l/c)}$$

**Transfer Impedance** 

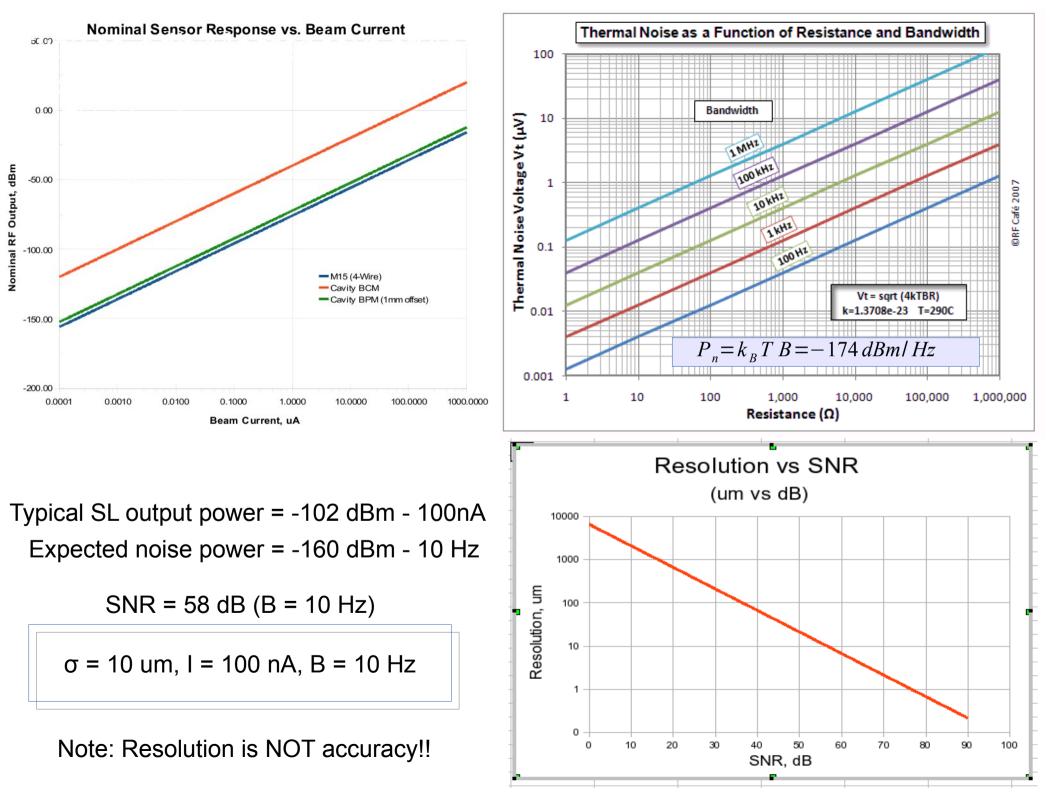
# **Resolution Analysis**



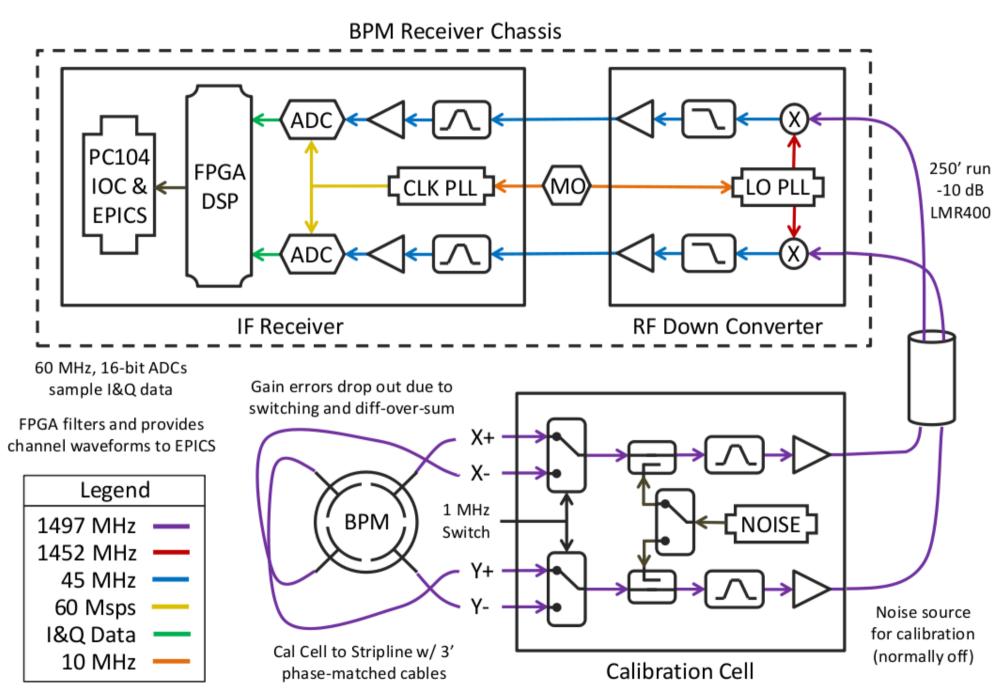
$$\sigma_{X} = \frac{a}{(V_{R} + V_{L})^{2}} \cdot \sqrt{V_{L}^{2} \delta V_{R}^{2} + V_{R}^{2} \delta V_{L}^{2}}$$

At boresight....

$$\sigma_{X} = \frac{a}{2} \cdot \frac{\sqrt{2} \sigma_{v}}{2V} = \frac{a}{2\sqrt{2}} \cdot \frac{1}{\sqrt{SNR}} \qquad SNR = \frac{P_{s}}{P_{n}} = \frac{V_{s}^{2}}{V_{n}^{2}}$$



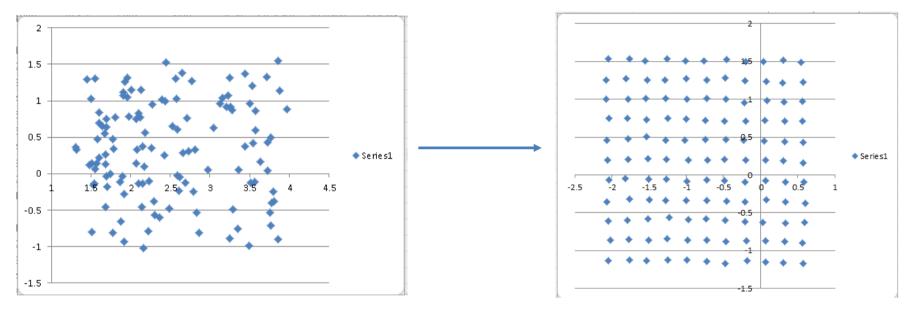
# **Stripline BPM Electronics**



#### **BPM Test Stand Stripline Electronics Testing**

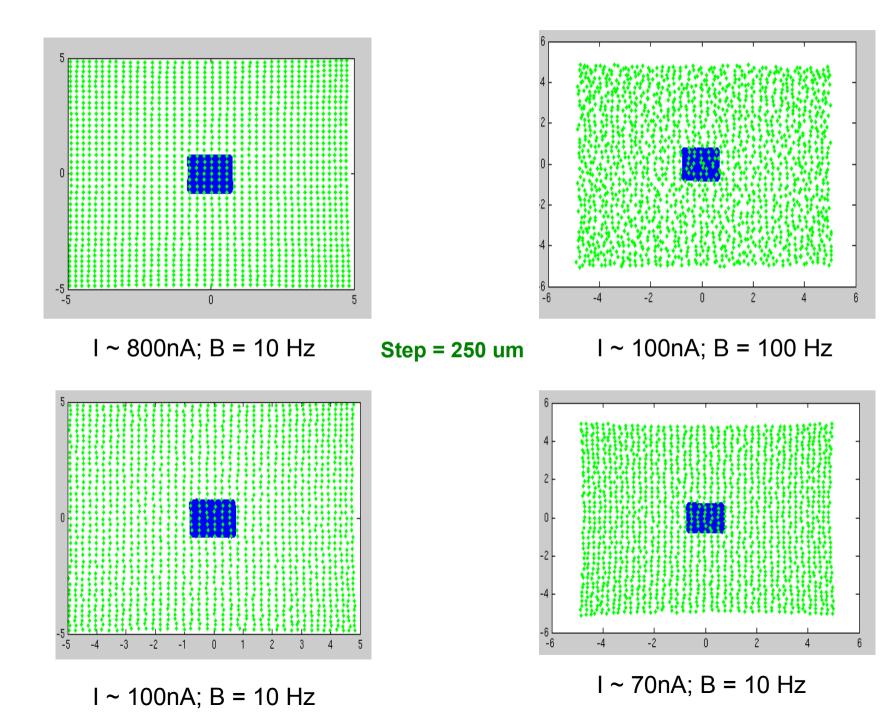
~30nA @ 10 Hz



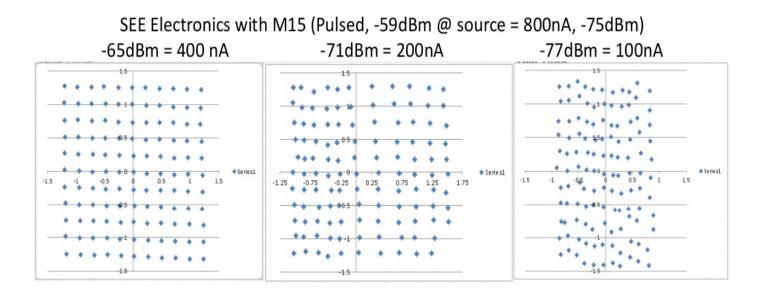


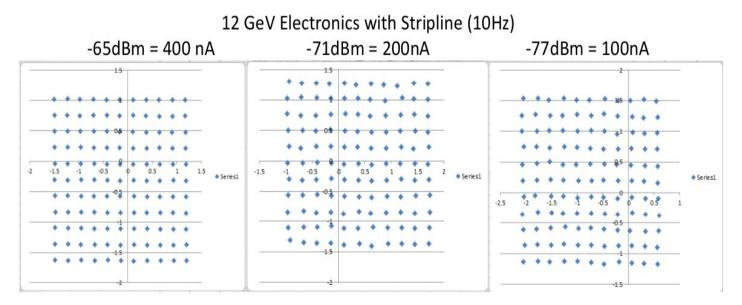
- Improving the signal-to-noise improves performance
- Filtering down to 1 Hz instead of 10 Hz gives an improvement factor of about 3 (excessive noise is due to algorithm)
- This square root of bandwidth improvement holds true as long as the noise is Gaussian
- Scan: 250 um/step, yielding 10s of um resolution (per calc)

#### Resolution

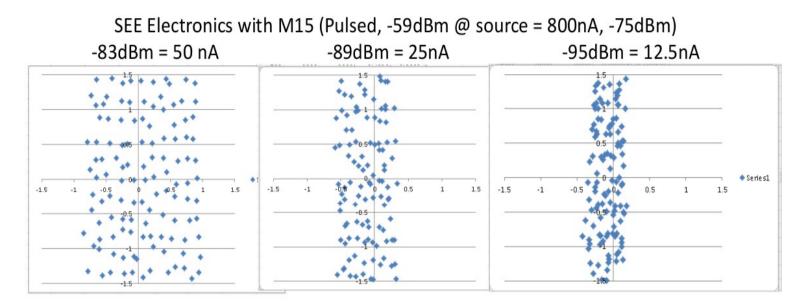


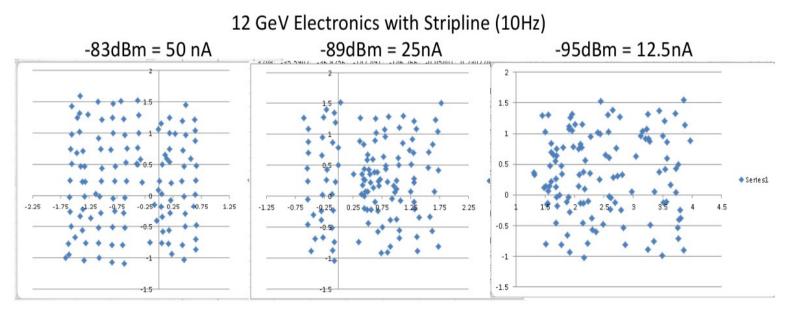
#### **Resolution (cont.)**





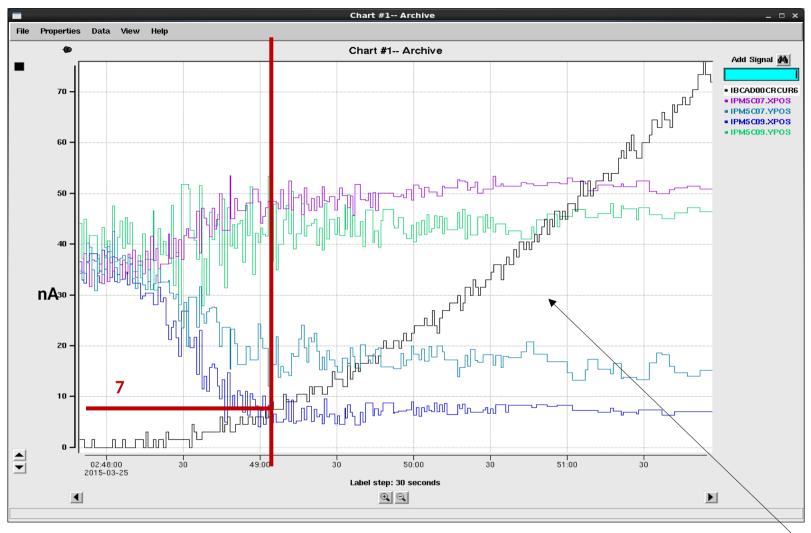
#### **Resolution (cont.)**





Premature signal breakup mainly due to algorithm inefficiencies.....

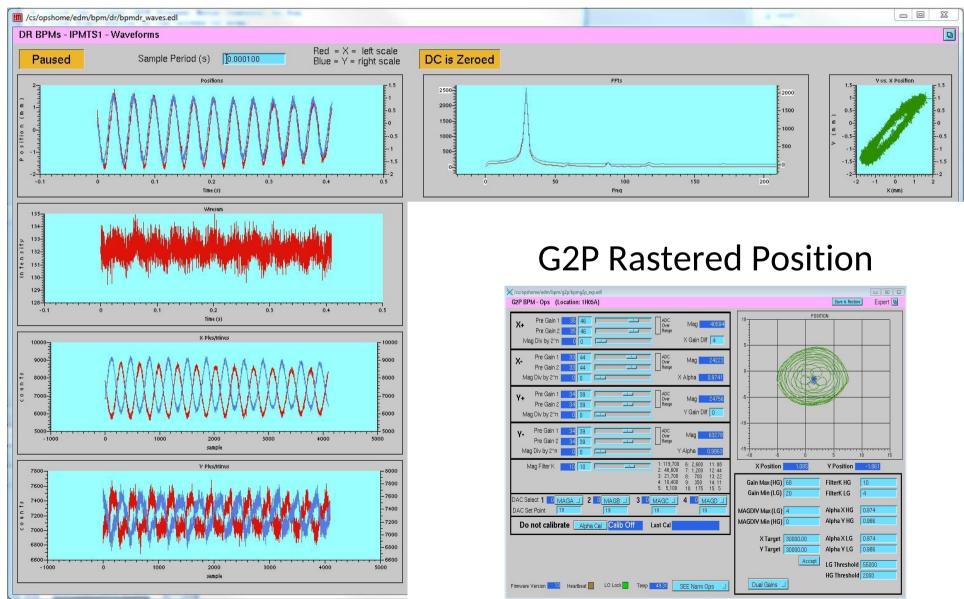
## **Stripline BPM Testing**



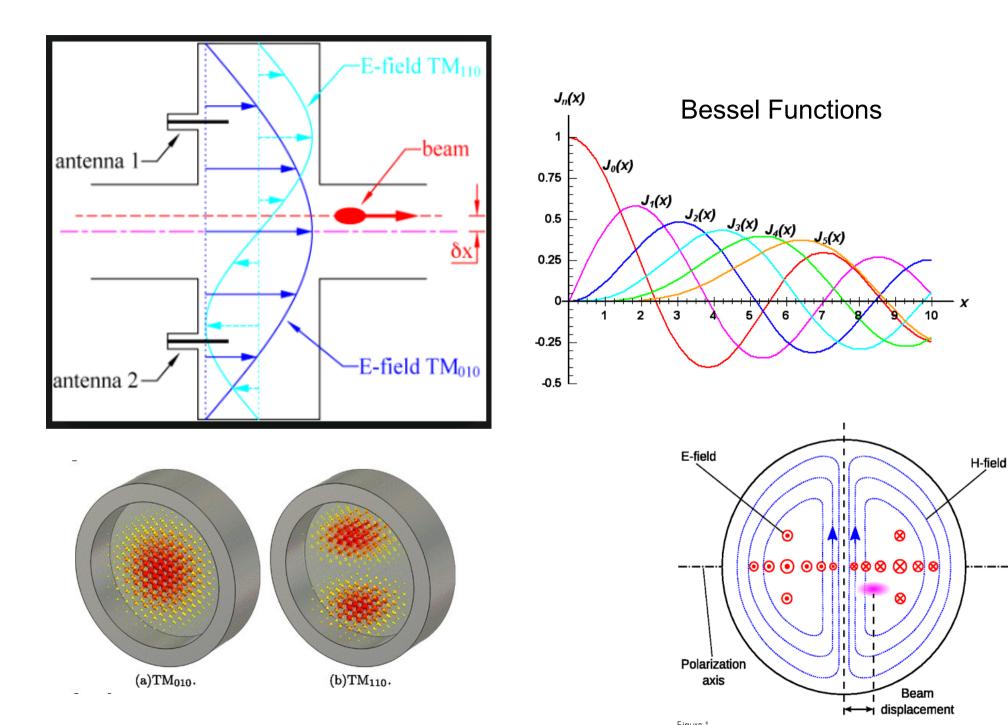
- Hall D current in black ramping from 0 to 75 nA
- The 5C07 and 5C09 BPM positions settle at ~7nA and accuracy improves as the signal-to-noise goes up (bandwidth of ~1Hz)

## Stripline BPM Software

#### Screen Shot of ~30Hz Oscillation (Time & Frequency Plots)



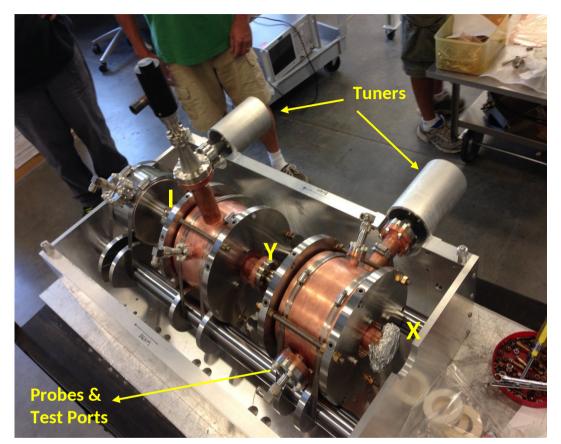
### **Cavity Modes**



# **Cavity Beam Position Monitors**

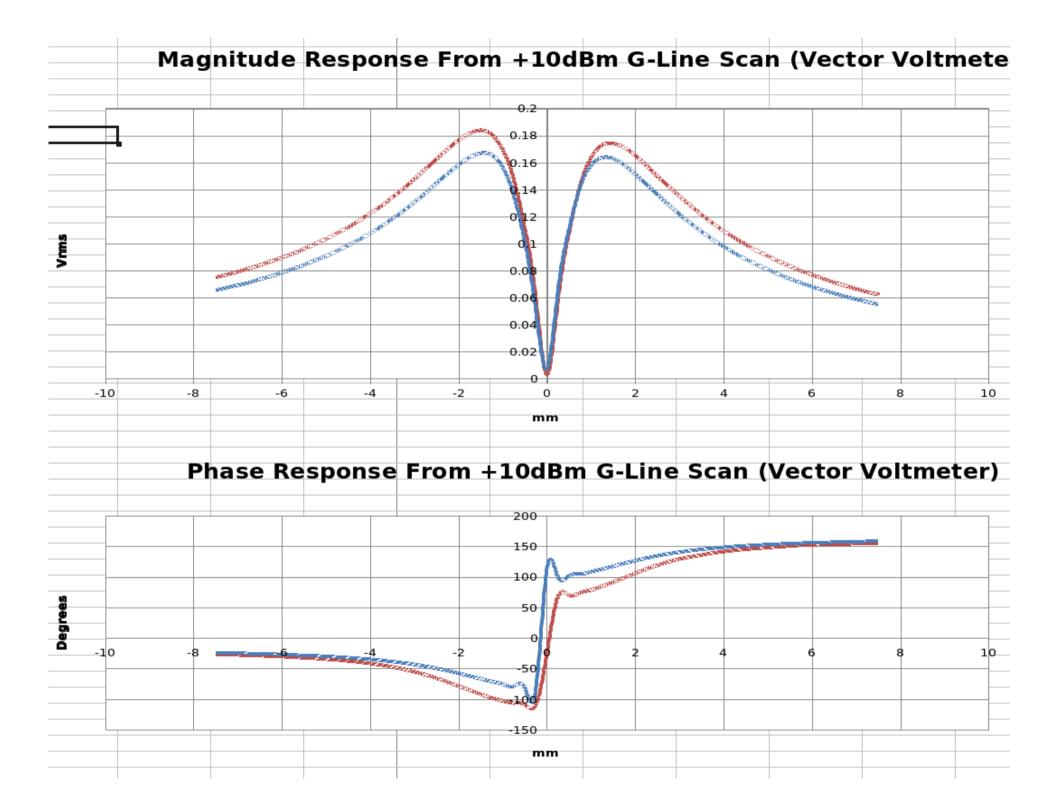
- Electromagnetic field excited by beam
  - TM110 Mode
  - Probe antenna picks up field
  - Test also used to excite field
  - Copper coated to increase Q
  - Signal disappears at boresight!
- Tuning port for centering at 1497MHz
  - Annually/vacuum broken
  - Temperature stabilized
- 1497 MHz Probe signals get down converted
- Positions go as X/I and Y/I
- IPM5C11A & IPM5C11C

<u>P = - 92 dBm @ 100um - uA</u>

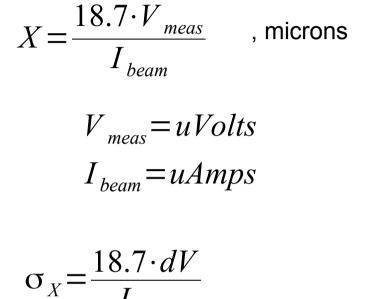






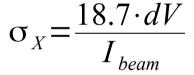


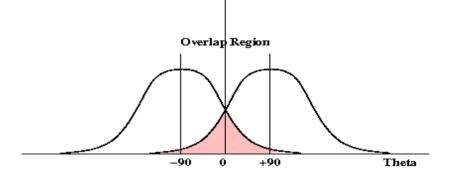
## **Resolution Analysis**



(k = 18.7 derived from MAFIA simulations, SS304)

Compared to stripline, cavity performance is *potentially* ~24 times better (100 nA, B = 10 Hz)





For NF = 4 dB, B = 10 Hz, I = 100 nA:

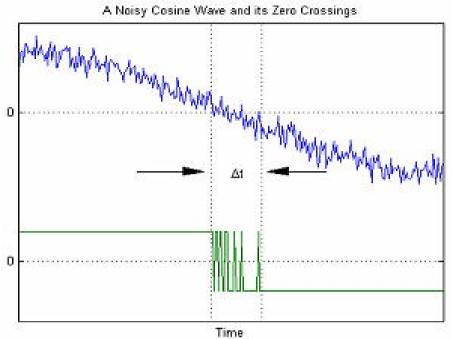
 $\sigma_{x} = 0.417 \, um$ 

"Baggage" imposed by non-linear phase detection

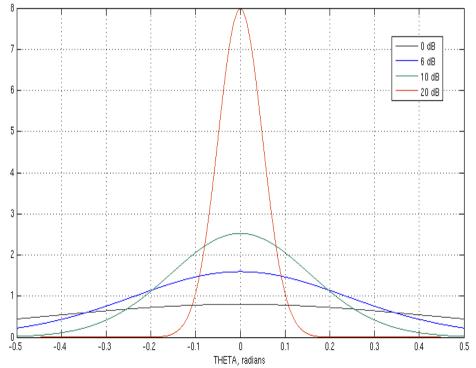
Dead-band at boresight =  $2\sigma_X$ 

Performance scales as I, sqrt(B)

Cu plating improves Q by 10, with (theoretically) equal improvement in resolution



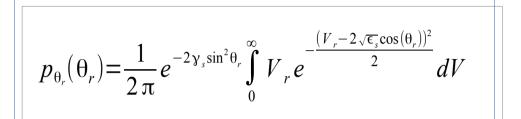
Angular PDF vs SNR, Arbitrary Units



#### **Phase Detection Penalty**

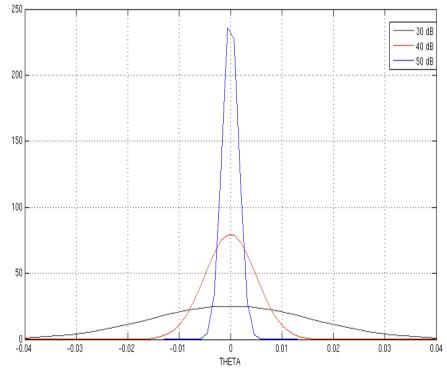
(Tech Note pending...)

Angular PDF vs SNR.

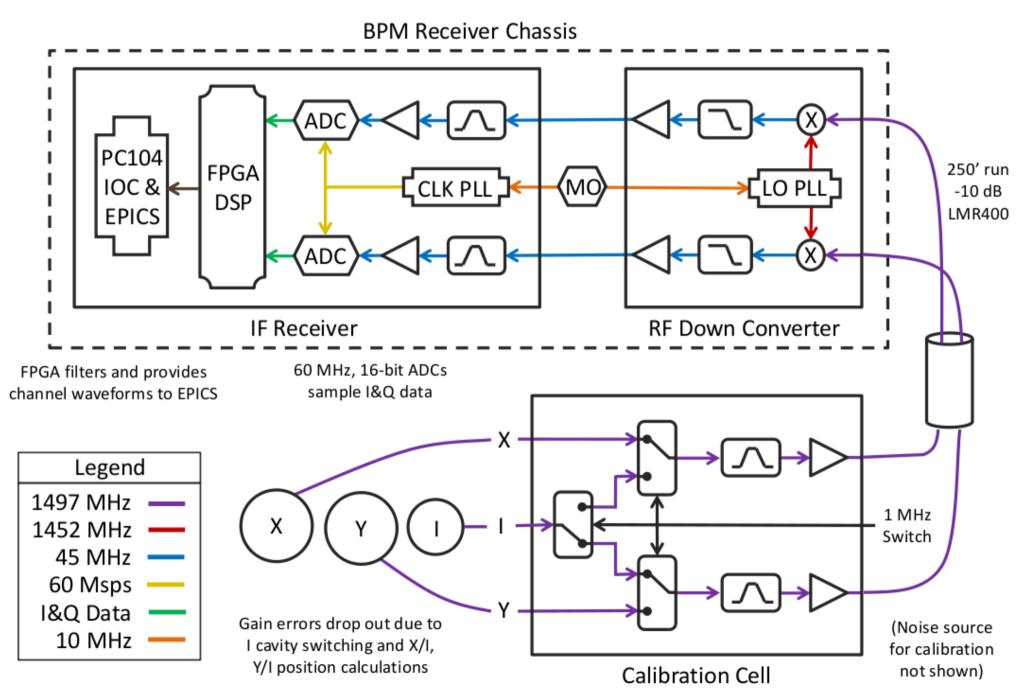




Angular PDF vs SNR, Arbitrary Units

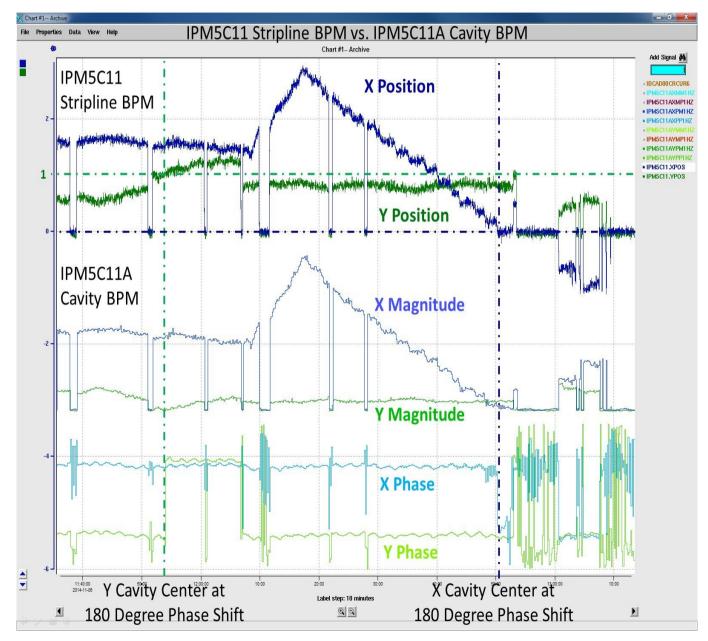


# **Cavity BPM Electronics**

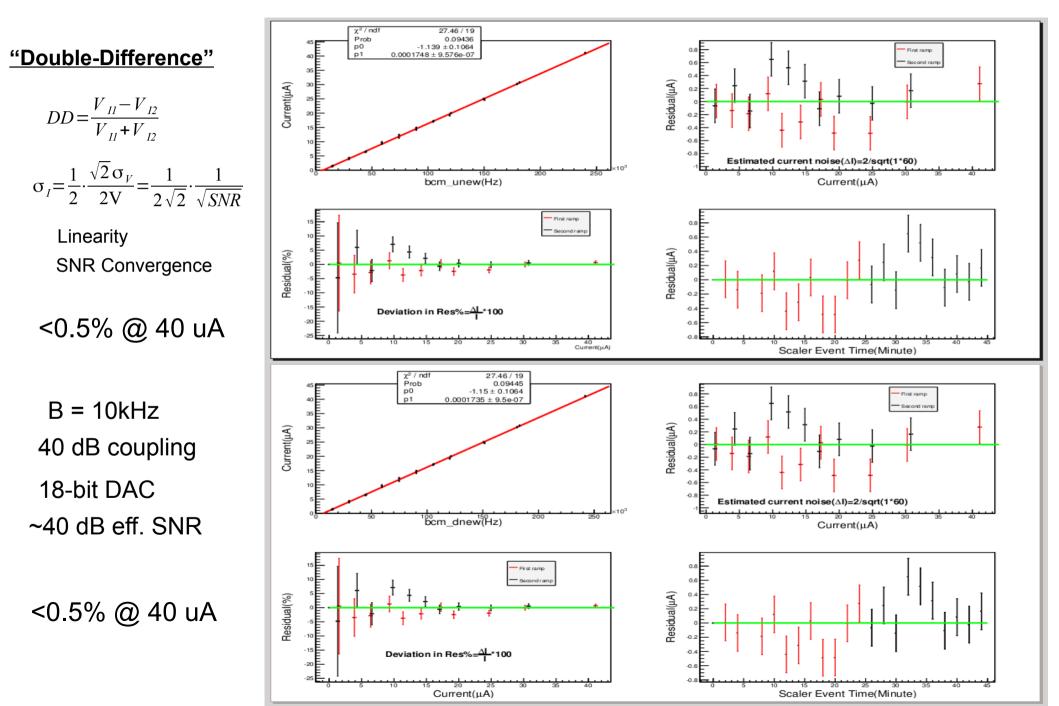


# Cavity BPM Testing ('5C11)

- Behaves as expected vs. Stripline BPM
- Signal goes to zero at cavity center
  - Phase shifts 180 degrees
  - Phase used to determine sign of position
- More commissioning time needed
- Aim to have valid positions down to 100pA beam currents at 1Hz



## Hall A BCM Commissioning Run, 4/15



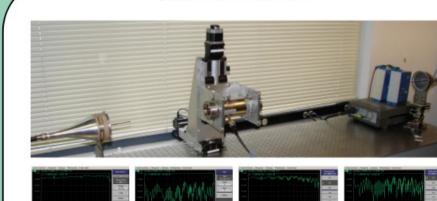
#### **Application Of Goubau Surface Wave Transmission Line** For Improves Bench Testing Of Diagnostic Beamline Elements\*

J. Musson, K. Cole, Thomas Jefferson National Accelerator Facility, Newport News, VA S. Rubin, Rubytron, Port Chester, NY

Goubau Line/BPM Test Fixture

#### Abstract

In-air test fixtures for beamline elements typically utilize an X-Y positioning stage, and a wire antenna excited by an RF source. In most cases, the antenna contains a standing wave, and is useful only for coarse alignment measurements in CW mode. A surface-wave (SW) based transmission line permits RF energy to be launched on the wire, travel through the beamline component, and then be absorbed in a load. Since SW transmission lines employ travelling waves, the RF energy can be made to resemble the electron beam, limited only by ohmic losses and dispersion. Although lossy coaxial systems are also a consideration, the diameter of the coax introduces large uncertainties in centroid location. A SW wire is easily constructed out of 200 micron magnet wire, which more accurately approximates the physical profile of the electron beam. Benefits of this test fixture include accurate field mapping, absolute calibration for given beam currents, Z-axis independence, and temporal response measurements of subnanosecond pulse structures. Descriptions of the surface wave launching technique, transmission line, and instrumentation are presented, along with measurement data.





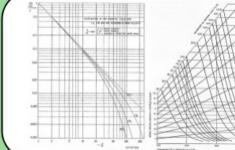


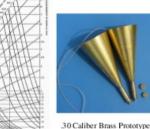
Insertion Loss (S21) plot of Return Loss (S11) plot of 1.6 mm diameter RadWire 1.6 mm diameter Rad Wire Insertion Loss (S21) plot of Return Loss (S11) plot of 160 um diameter RadWire 160 um diameter RadWire



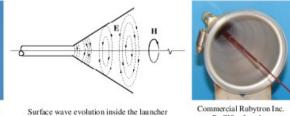








#### **Development Of Surface Wave Lancher**



RadWire Lancher

#### Conclusions

Traditional bench testing of beamline components will be inadequate to characterize and assess performance of the 12 GeV upgrade at Jefferson lab. The use of the G-line facilitates measurements which more accurately mimic electron beam conditions. This system is particularly well-suited for our bench system, due to ease of fabrication, low-cost, and choice of operating frequency range. In addition, due to the flat 8 GHz frequency response, pulsed beam structures can be replicated, providing a platform for receiver development. Further reduction of VSWR is planned, in order to minimize dispersion of pulses resulting from reflections. Finally, the use of ~1 um X-Y stages presents a system which can be automated, improving repeatability and simplifying test procedures.



\*Authored by Jefferson Science Associates, LLC under U.S. DOE Contract No. DE-AC05-06OR23177. The U.S. Government retains a non-exclusive, paid-up, irrevocable, worldwide license to publish or reproduce this manuscript for U.S. Government purposes.



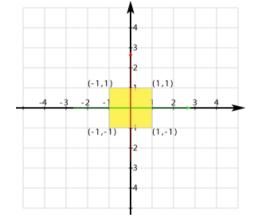
## LMS 2-D Field Map Transformations

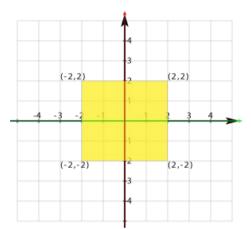
Translation

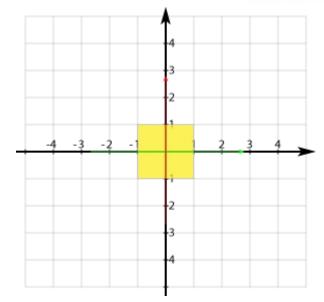
$$\begin{bmatrix} x' \\ y' \\ 1 \end{bmatrix} = \begin{bmatrix} 1 & 0 & d_x \\ 0 & 1 & d_y \\ 0 & 0 & 1 \end{bmatrix} \begin{bmatrix} x \\ y \\ 1 \end{bmatrix}$$

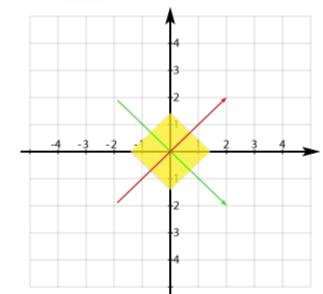
- Scaling
- $\begin{bmatrix} x' \\ y' \\ 1 \end{bmatrix} = \begin{bmatrix} s_x & 0 & 0 \\ 0 & s_y & 0 \\ 0 & 0 & 1 \end{bmatrix} \begin{bmatrix} x \\ y \\ 1 \end{bmatrix}$
- Rotation

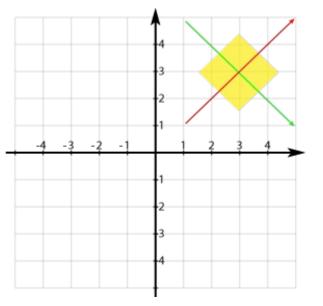
 $\begin{bmatrix} x' \\ y' \\ 1 \end{bmatrix} = \begin{bmatrix} \cos\theta & -\sin\theta & 0 \\ \sin\theta & \cos\theta & 0 \\ 0 & 0 & 1 \end{bmatrix} \begin{bmatrix} x \\ y \\ 1 \end{bmatrix}$ 









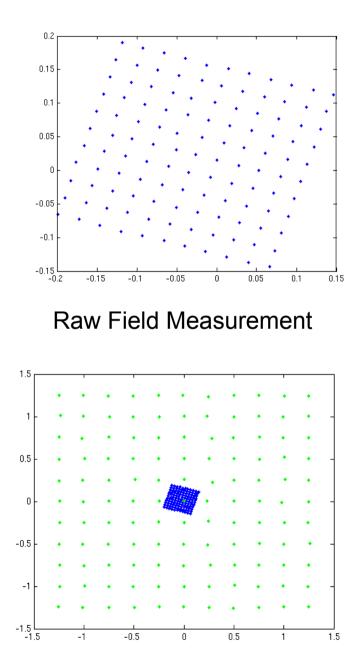


#### **Physical Significance**

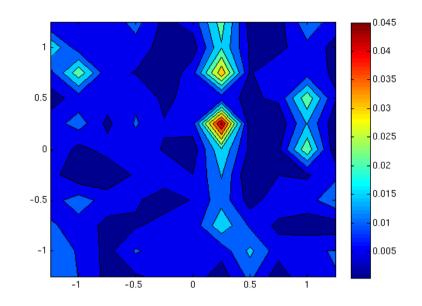
$$\begin{aligned} X_{scale factor} = \sqrt{\alpha_x^2 + \beta_x^2} & \text{Scale factors for X and Y directions} \\ Y_{scale factor} = \sqrt{\alpha_y^2 + \beta_y^2} & \text{Scale factors for X and Y directions} \\ \theta_x = \tan^{-1}(\frac{\beta_x}{\alpha_x}) & \text{X and Y "effectively" rotated individually} \\ \theta_y = \tan^{-1}(\frac{\beta_y}{\alpha_y}) & \text{Differences in thetas represents X-Y coupling} \\ \Delta \theta = \theta_y - \theta_x & \text{Differences in thetas represents X-Y coupling} \\ \Delta_x, \Delta_y & \text{Arbitrary field offset;} \\ \text{Merely tells us where we "should" have started the scan} \end{aligned}$$

Not related to physical vs. electrical centers (obtained later)

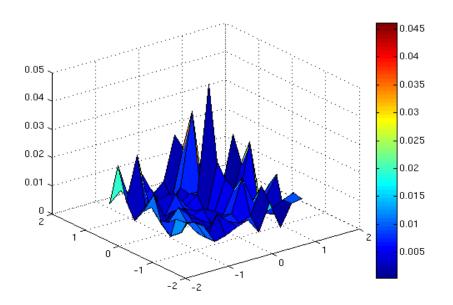
#### **Algorithm Verification**



Scaled, Rotated, Translated....

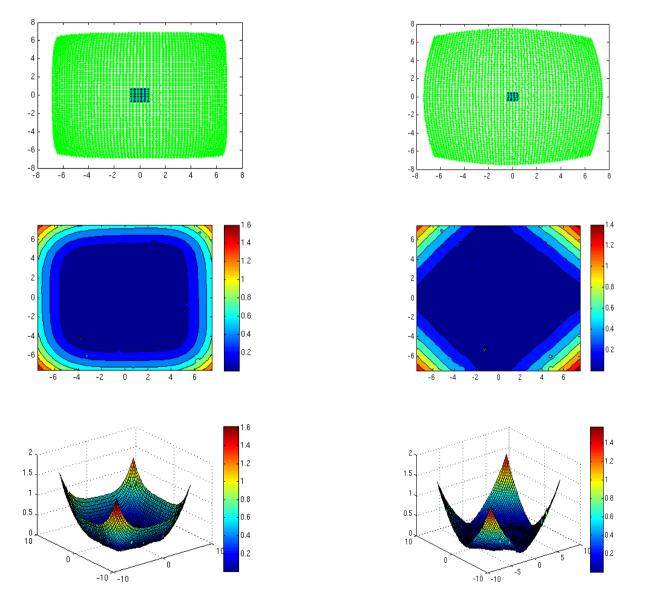


**RMS Error Vector Magnitudes** 



#### SPM vs M15 Scans

LMS per 1cm x 1cm



SPM

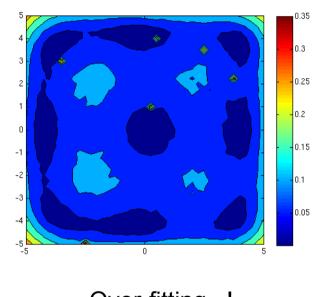
M15

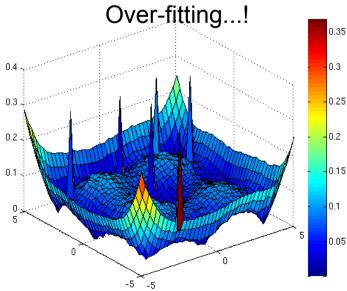
Step size = 250 um

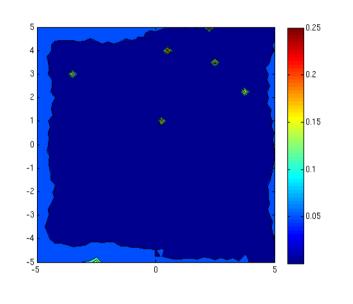
### LMS Fit: 1 cm<sup>2</sup> (SPM 26)

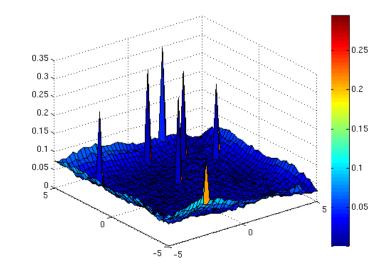
#### **Linear Fit**

Log Fit



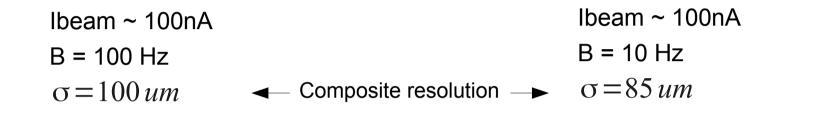


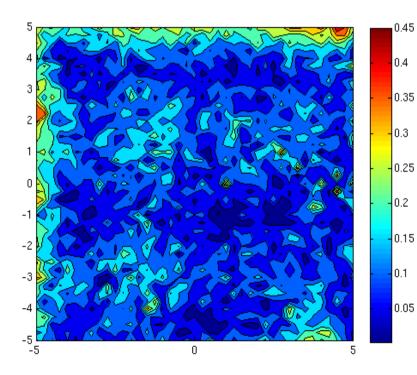


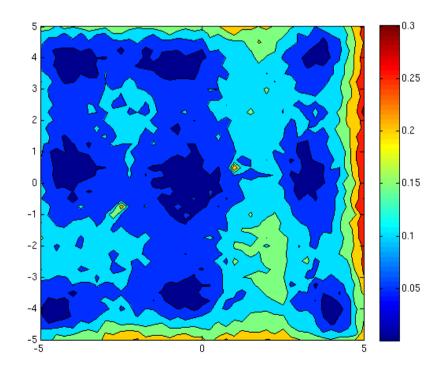


## **Position Accuracy (SPM)**

$$f(x;\sigma) = \frac{x}{\sigma^2} e^{-x^2/2\sigma^2}, \quad x \ge 0,$$
 Rayleigh Distribution



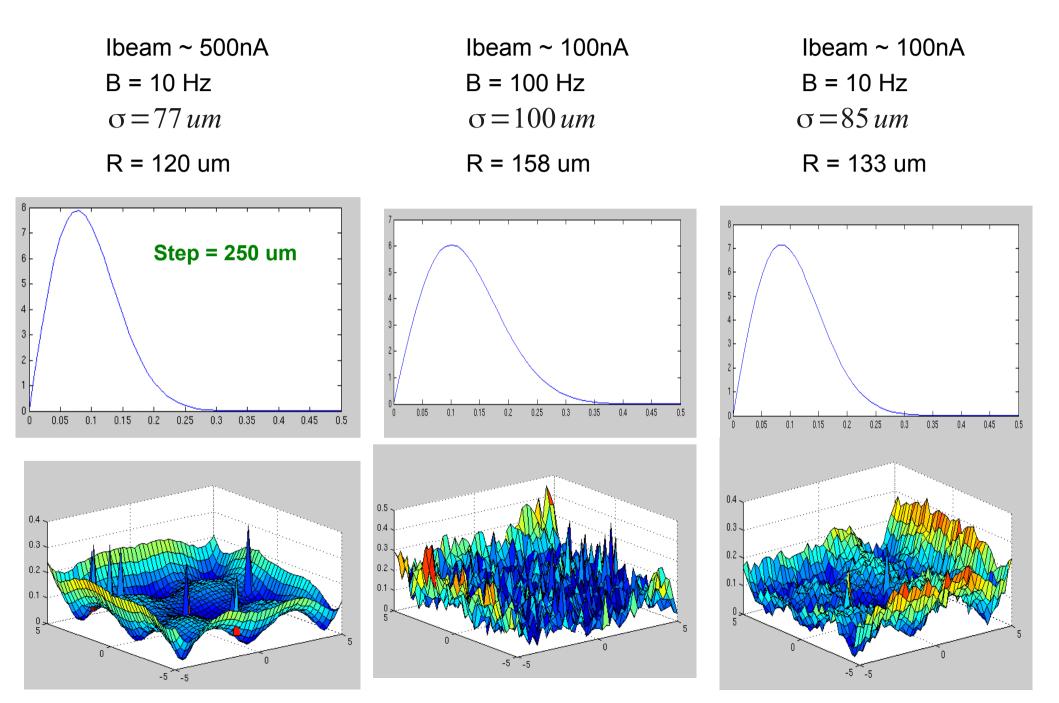




1cm x 1cm

1cm x 1cm

### **Position Accuracy (cont.)**



# Conclusions

- SL BPM is a relative sensor, with resolution dependent on SNR
- Cavity system has better magnitude response, but contains phase detection "baggage"
- Realized improvement at 100 nA, 10 Hz is ~8x (no Cu plating)
- · Cavity calibration is rather involved, requiring additional beamline elements as fiducials
- New electronics are vastly more configurable:
  - Resolution (NF), Lineartity (DR), and output BW are competing factors
- Important numbers:
  - Pn = -174 dBm / Hz
  - SL BPM -80 dBm @ 1uA (scales 20log for I, 10log forB)
  - Cavity -92 dBm @ 100um 1 uA
  - Electronics: \$5k per system
  - Elements:
    - SL~\$1K
    - Cavity system ~\$100k!
- SL BPM > 7nA (1 Hz)
- Cavity BPM >100 pA (1 Hz, Cu-plated)
- Cavity BCM already confirmed to 100s of pA (see Grames ELOG)

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